| | Application/Control No. | Applicant(s)/Patent Under Reexamination |
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| Issue Classification | 10613494 | LEE, JUN-YOUNG |
| | Examiner | Art Unit |
| | Moon, Seokyun | 2629 |

| | ORIGINAL | AL | INTERNATIONAL | INTERNATIONAL CLASSIFICATION | |
|------------------------------|-----------------------|--------------------------------------------|---------------------|------------------------------|-----------------------------|
| | CLASS | SUBCLASS | CLAIMED | NON-CLAIMED | |
| 345 | | 09 | G 0 9 G 3/28 | | |
| | CROSS REFERENCE(S) | RENCE(S) | | | |
| CLASS | SUBCLASS (ON | SUBCLASS (ONE SUBCLASS PER BLOCK) | | | |
| 345 | 41 | | | | |
| 315 | 169.4 | | | | |
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| Seokyun Moon | 1/19/2007 | | | Total Claims Allowed: | ë |
| (Assistant Examiner) | | AMR A. AWAD SUPERVISORY PATENT EXAMINER | IAD NT EXAMINER | 18 | |
| (Legal Instruments Examiner) | ents Examiner) (Date) | (Primary Examiner) | > 1-22-07 (Date) | O.G. Print Claim(s) O.G. Pr | O.G. Print Figure Fig. 4 |
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